



Single photon counting hybrid pixel detectors

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Spokesman, Medipix2 Collaboration

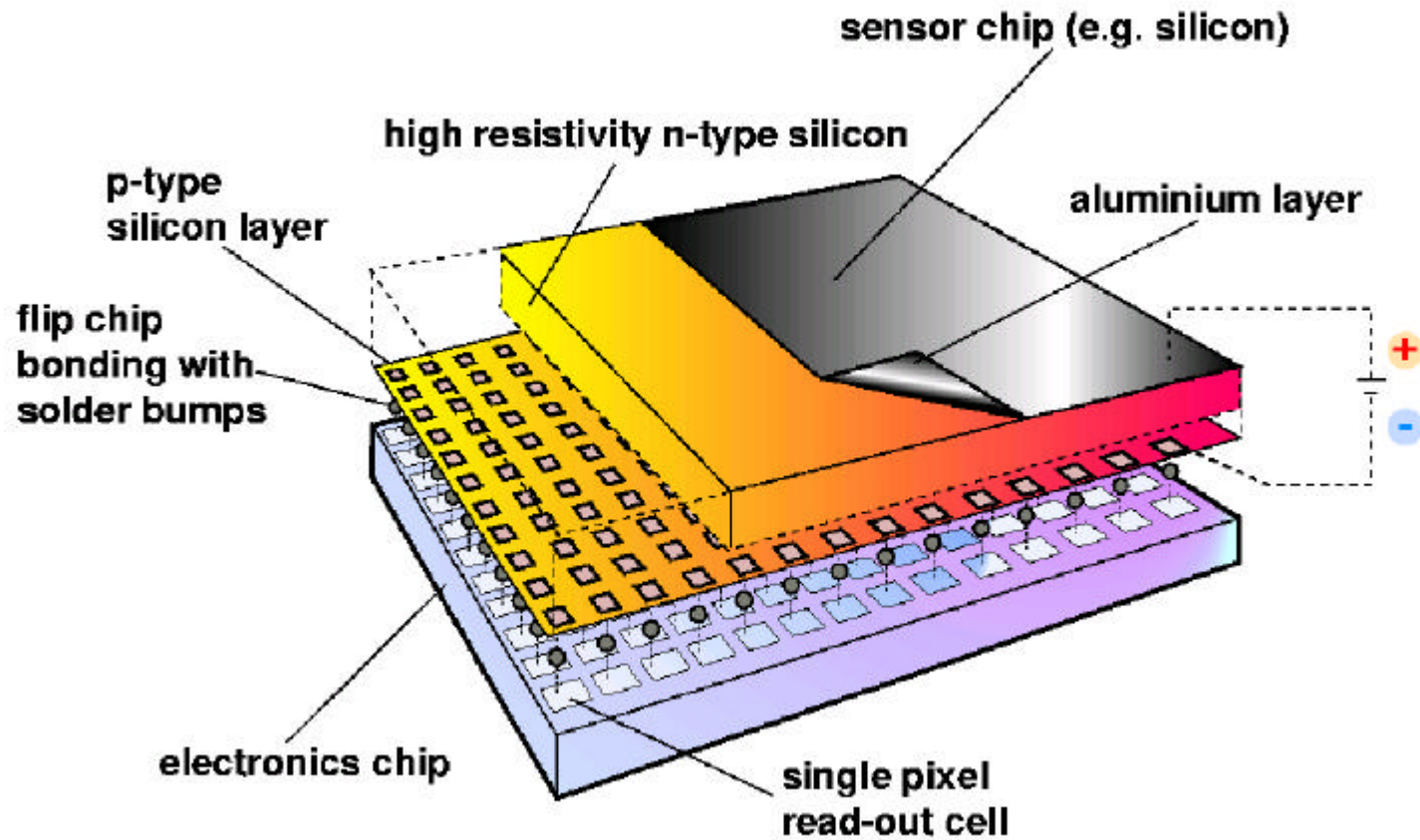


Outline

- ✍ **Hybrid pixel detector basics**
- ✍ **High Energy Physics applications**
 - ✍ **Origins in heavy ion physics**
 - ✍ **Towards the Large Hadron Collider**
 - ✍ **Radiation hardness of CMOS**
- ✍ **From single event processing to x-ray imaging**
- ✍ **Medipix1 – a 4k pixel chip**
- ✍ **Medipix2 - a 64k pixel chip**
- ✍ **Future developments**

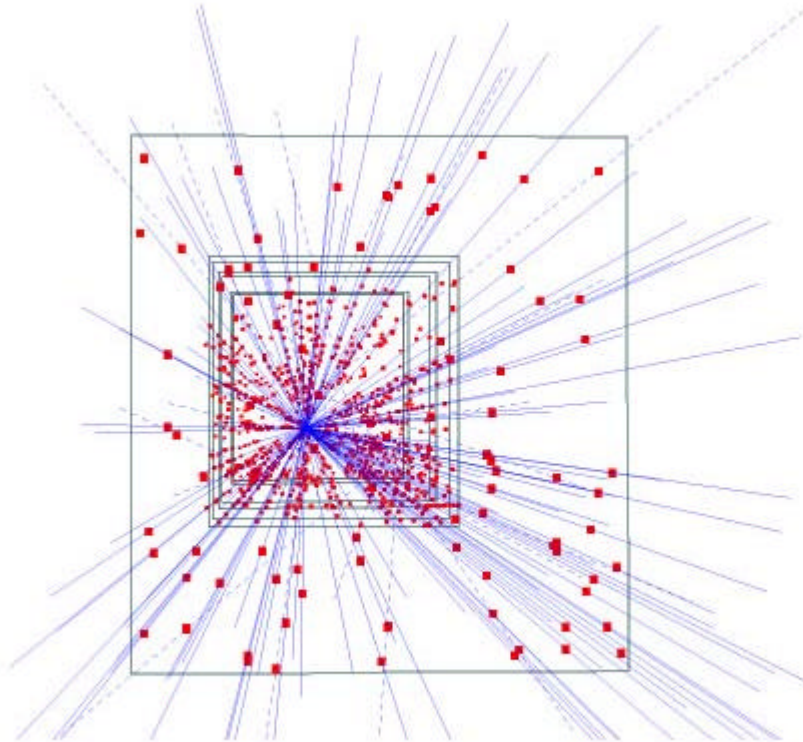


Hybrid Pixel Detector





The origins in Heavy Ion Physics



CERN Experiment WA97 (1995)

5 x 5 cm² area

7 detector planes

Pixel dimensions 75 x 500 μ m²

Trigger precision 1 μ sec

1 kHz trigger rate

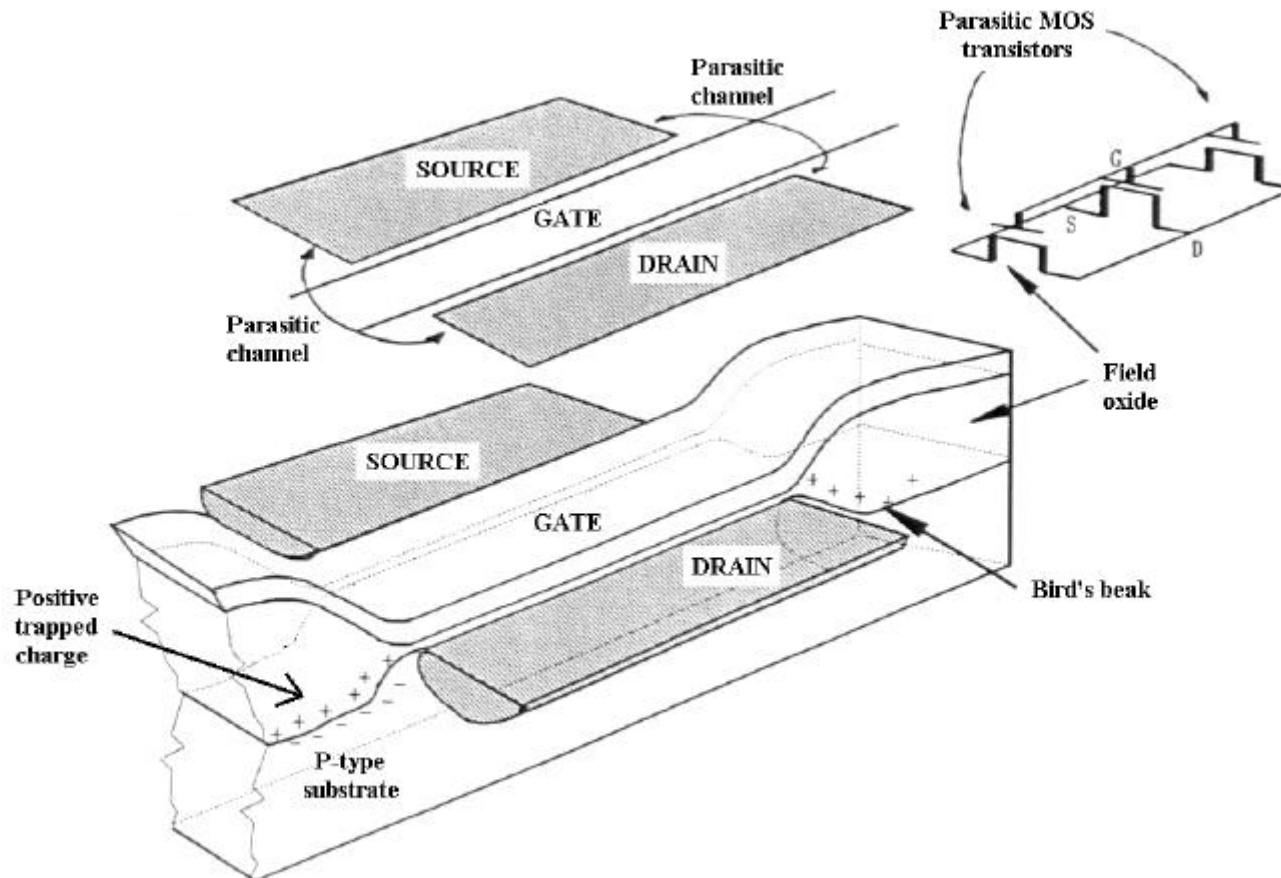


The Large Hadron Collider Challenge

- ✍ **40 million bunch crossings per second, each producing...**
- ✍ **About 1 000 tracks**
- ✍ **All tracks should be recorded but only a tiny subset read out**
- ✍ **The position information should be precise to about 10⁻⁷ m**
- ✍ **Some experiments >10MRad total dose**
- ✍ **Pixel systems must operate for years without access**
- ✍ **Pixel systems must be transparent to particles**
- ✍ **Pixel systems should consume minimal power**



Effect of ionizing radiation on CMOS transistors - total dose

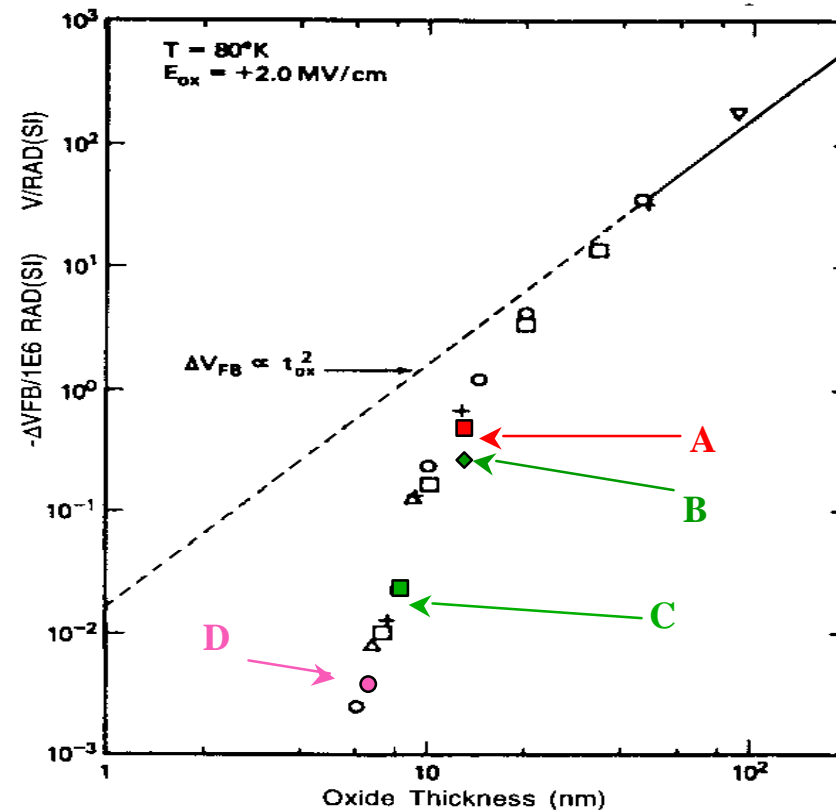


R. Gaillard, J.-L. Leray, O. Musseau, "Techniques de durcissement des composants, circuits et systems électroniques," Notes of the short course of the 3rd European Conference on Radiation and its Effects on Components and Systems, Arcachon (France), Sept. 1995.



MOS Flatband voltage shift versus gate oxide thickness after 1MRad(Si) @ 80°K

- ~~ⓧ~~ Tunneling of trapped charge in thin oxides
- ~~ⓧ~~ ? $V_T \sim 1/t_{ox}^2$ for $t_{ox} > 10\text{nm}$
- ~~ⓧ~~ ? $V_T \sim 1/t_{ox}^3$ for $t_{ox} < 10\text{ nm}$



After N.S. Saks, M.G. Ancona, and J.A. Modolo, IEEE Trans.Nucl.Sci., Vol. NS-31 (1984) 1249



Total ionizing irradiation dose problem in commercial CMOS

Radiation induces positive fixed oxide charge and interface states

V_t - shift

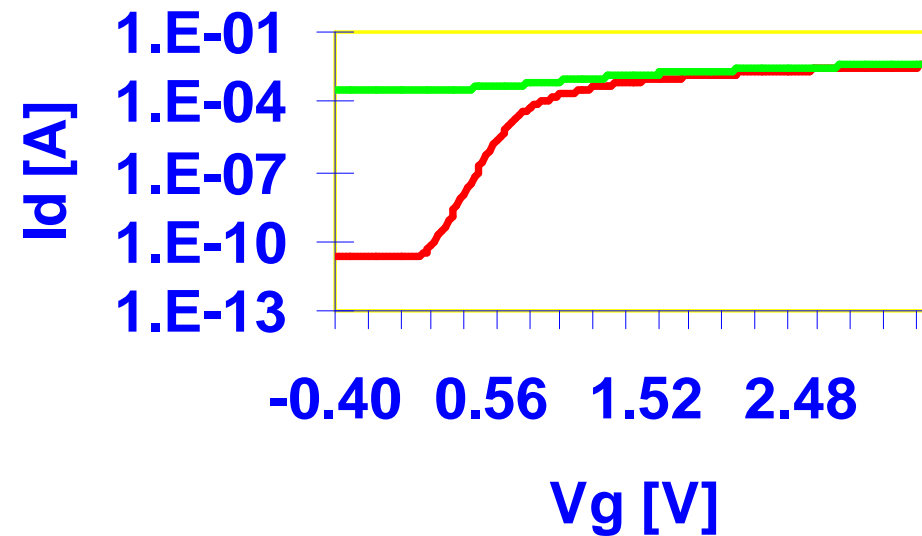
weak inversion slope change

mobility change

LEAKAGE in NMOS transistors

N-ch Standard W/L=10/0.5

— Prerad — After 2Mrad

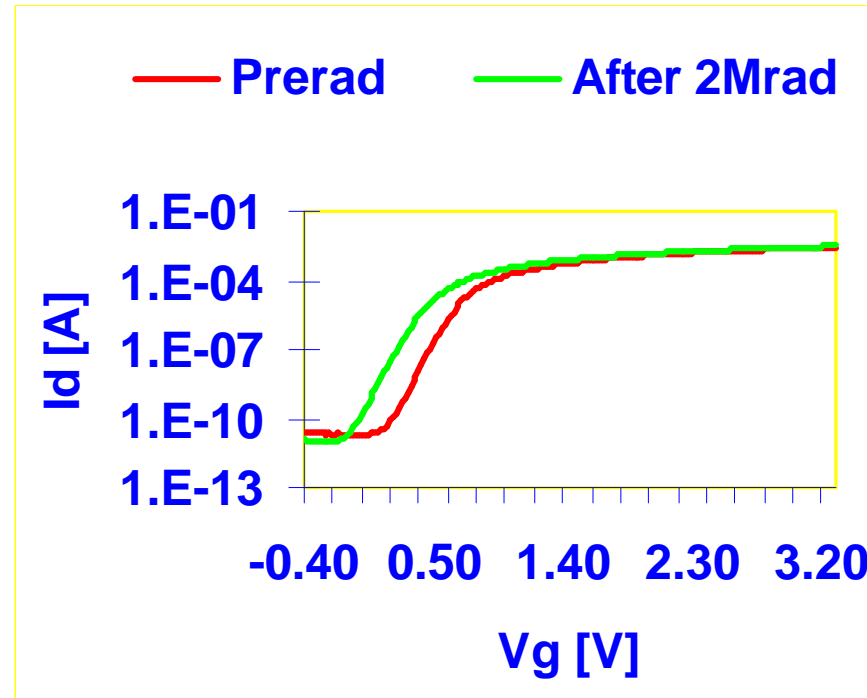
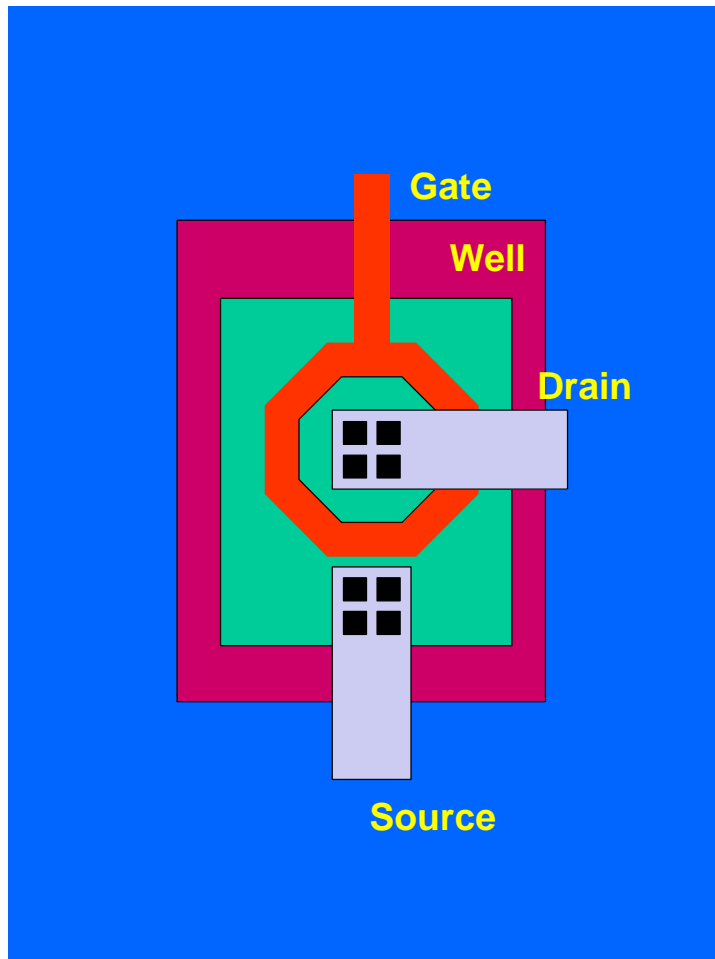


Example from 0.5 μ m technology (tox ~ 10 nm)



NMOS TRANSISTOR LEAKAGE

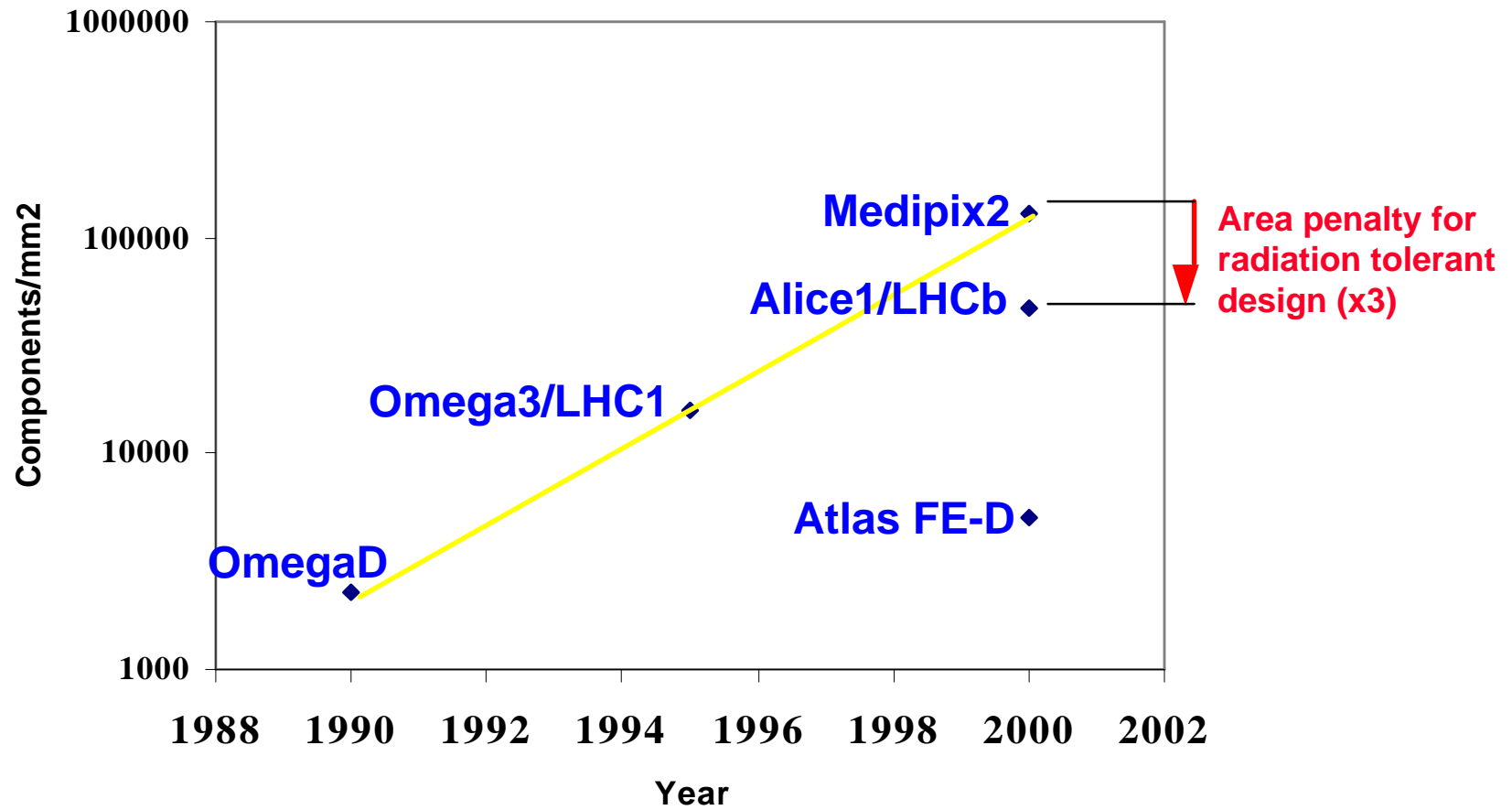
ENCLOSED TRANSISTOR LAYOUT



0.5um Technology ($t_{ox} = 10\text{nm}$)



Pixel readout chips- component density





From HEP to x-ray imaging

- ✍ **Pulse processing circuitry eliminates dark current noise**
- ✍ **But readout should be changed from HEP (event stored until trigger arrival) to single photon counting (using a shutter)**
- ✍ **HEP pixels are small, but the wrong shape - usually rectangular for momentum measurements in magnetic fields**
- ✍ **All HEP applications use high ρ silicon. For imaging front-end should allow both electron and hole collection**



Medipix1 chip

**based on ideas developed by the
RD19 collaboration (CERN)**

SACMOS1 FASELEC technology

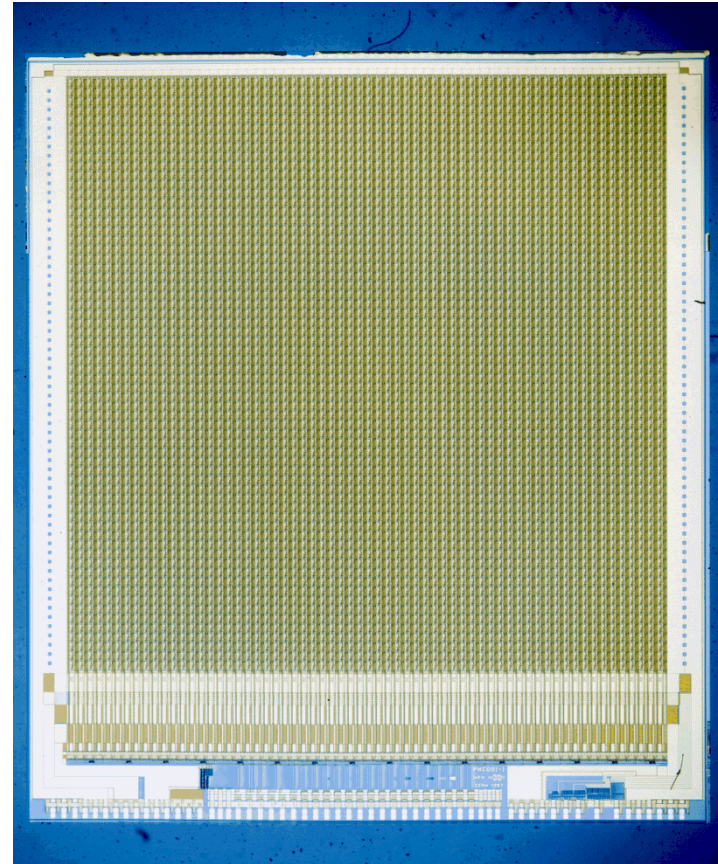
Matrix of 64 x 64 pixels

Pixel size 170 μ m x 170 μ m

1.2 cm² sensitive area

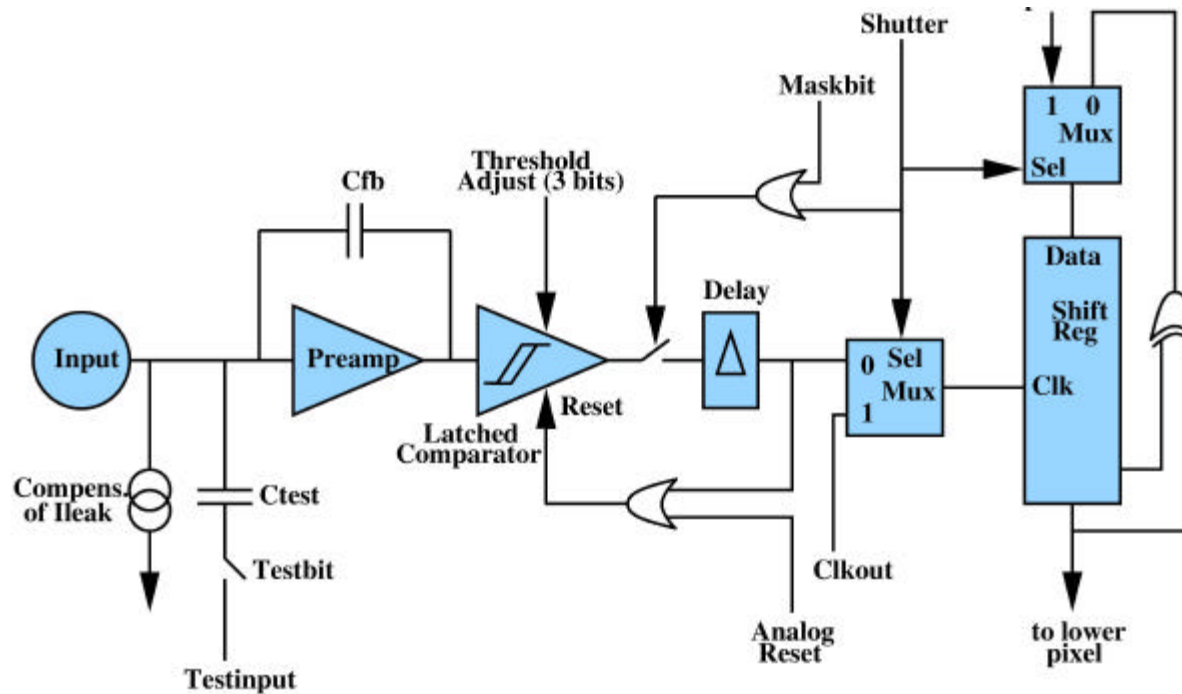
1.7 cm² total area

1.6 M transistors





Medipix1 – cell schematic



charge sensitive preamplifier with leakage current compensation

discriminator with globally adjustable threshold

3-bit local fine tuning of the threshold

1 test and 1 mask bit

external shutter activates the counter

15-bit pseudo-random counter

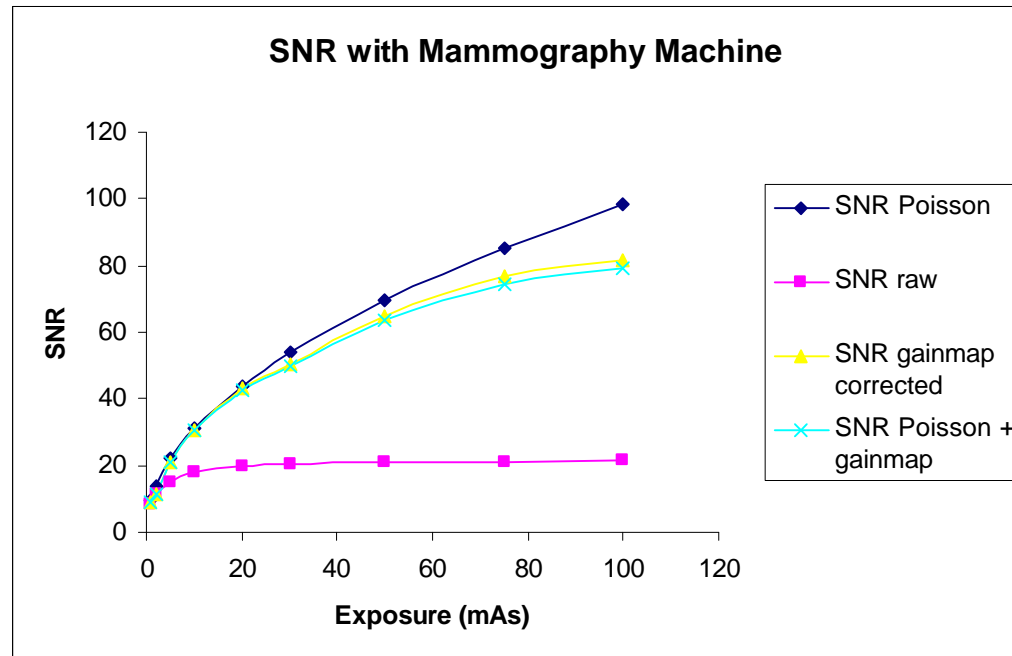
Max count rate 1MHz (continuous)

readout frequency: max. 10 MHz

readout time: 384 ? s



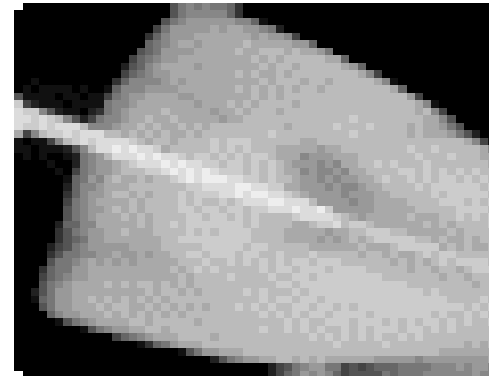
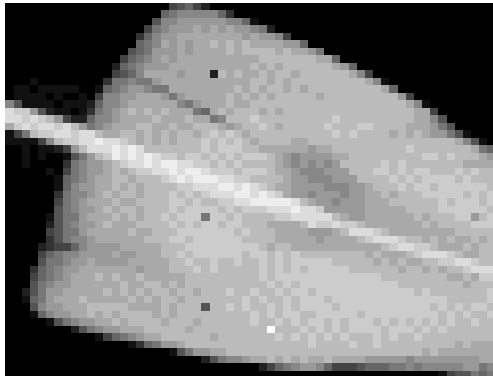
Measured SNR with Mammograph



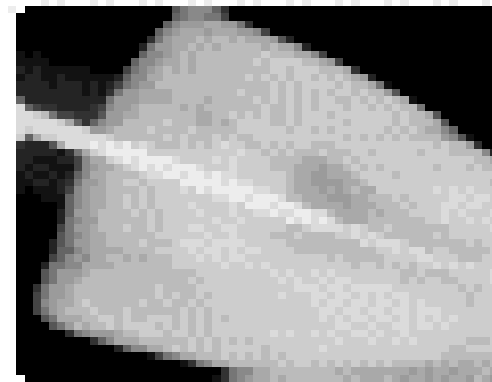
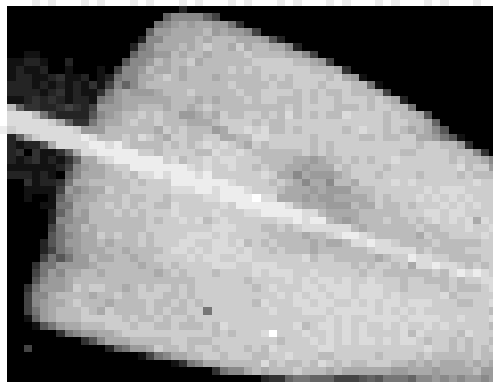
Note that exposure is at 2x normal distance



Examples of the performance of the Photon Counting Chip

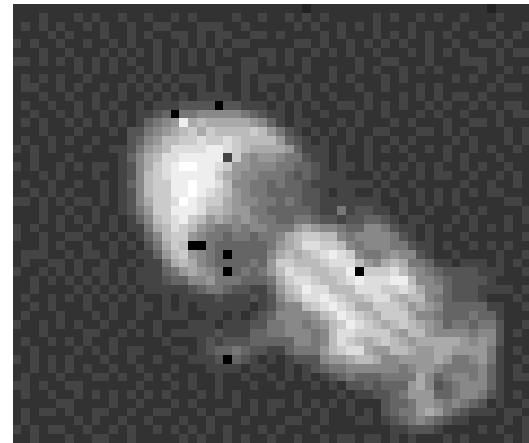


Images of a tooth taken with Medipix system.
The upper images use the standard dental x-ray settings.
The lower images use a dose reduced by a factor of 30.





Examples of the performance of the Photon Counting Chip

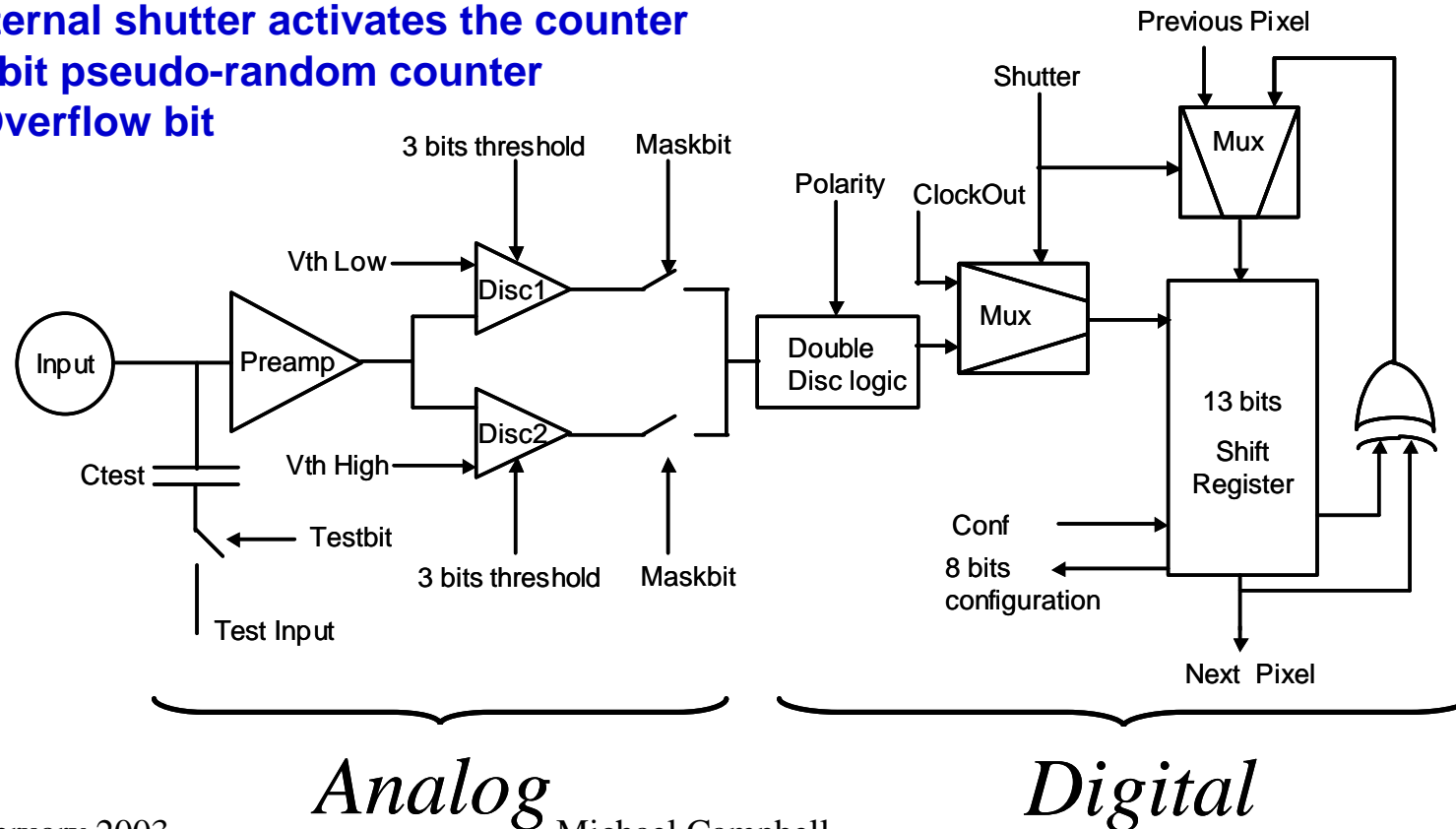


An x-ray image of a fly using an ^{55}Fe radioactive source (5.9keV).



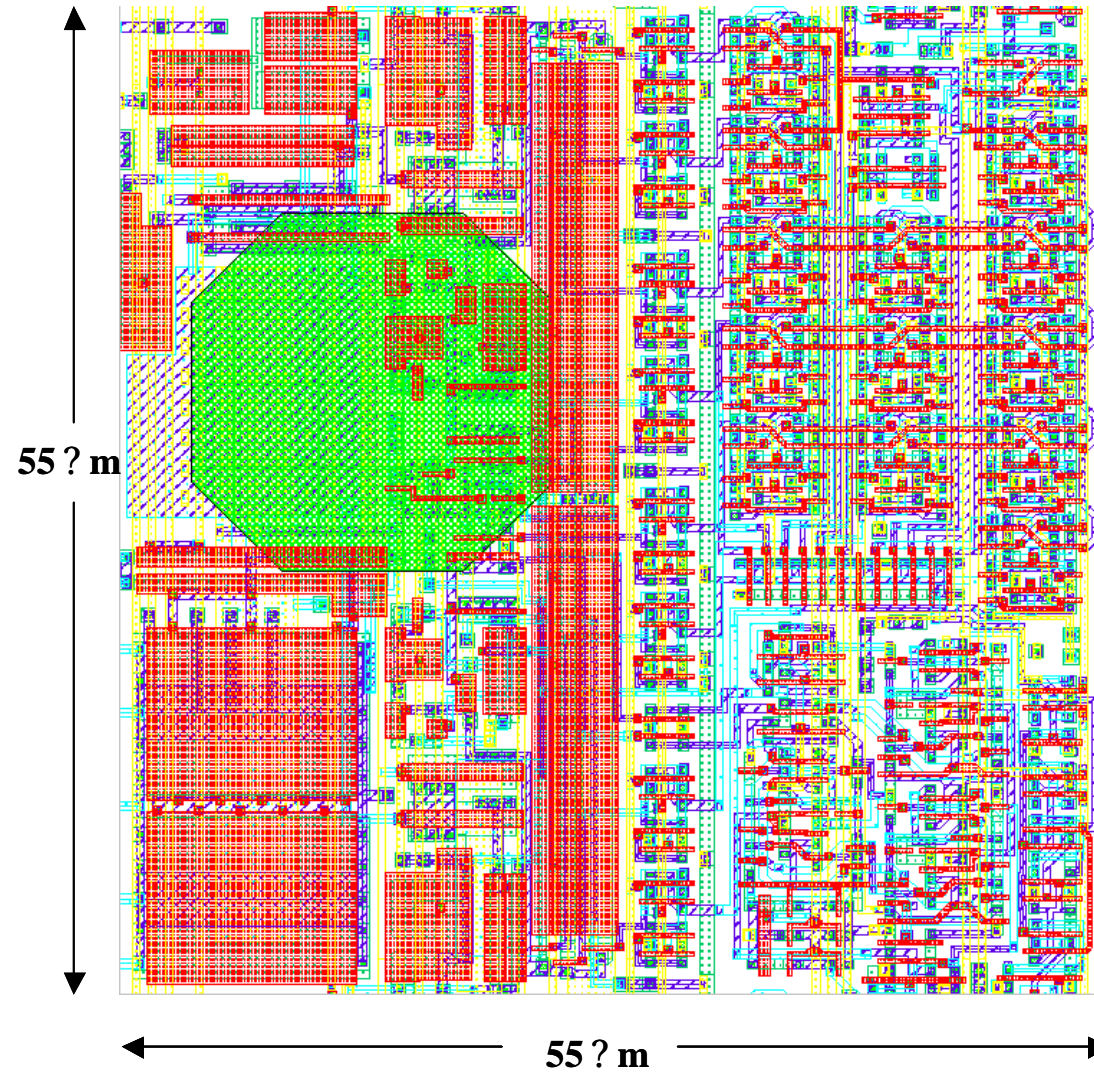
Medipix2 Cell Schematic

- Charge sensitive preamplifier with individual leakage current compensation
- 2 discriminators with globally adjustable threshold
- 3-bit local fine tuning of the threshold per discriminator
- 1 test and 1 mask bit
- External shutter activates the counter
- 13-bit pseudo-random counter
- 1 Overflow bit





Medipix2 Cell Layout

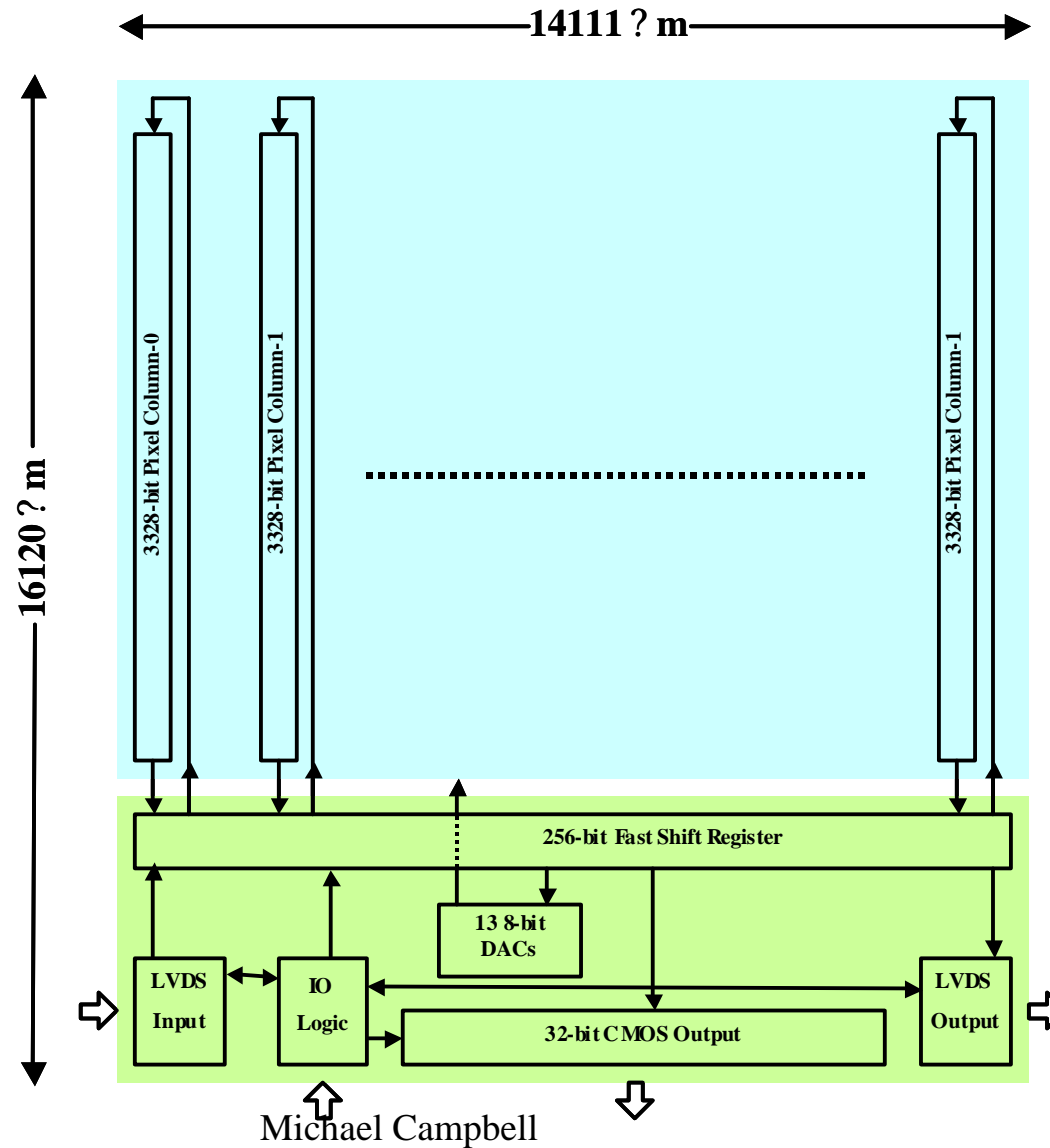


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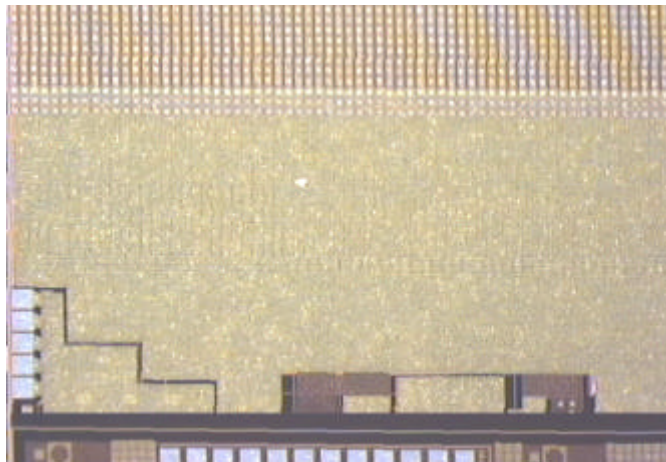
Medipix2 Chip Architecture



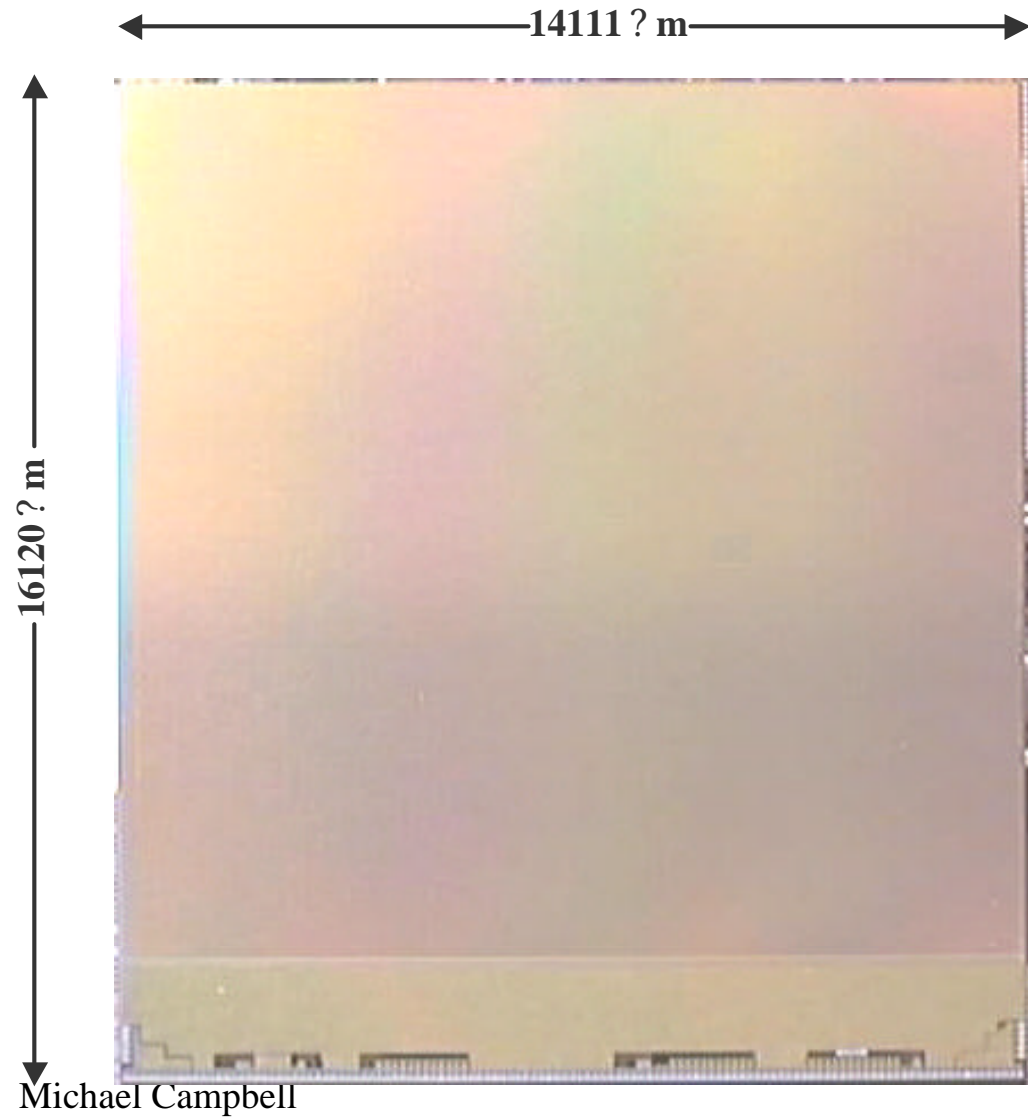
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Medipix2 Chip Architecture (II)



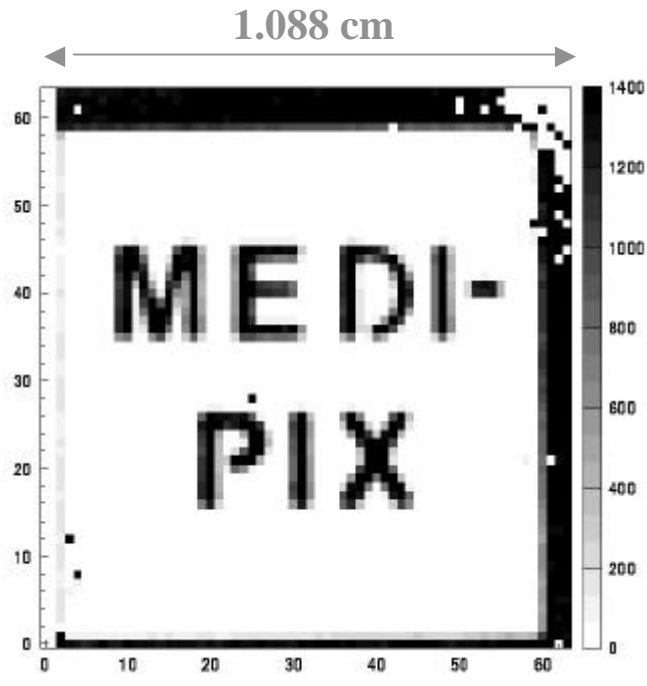
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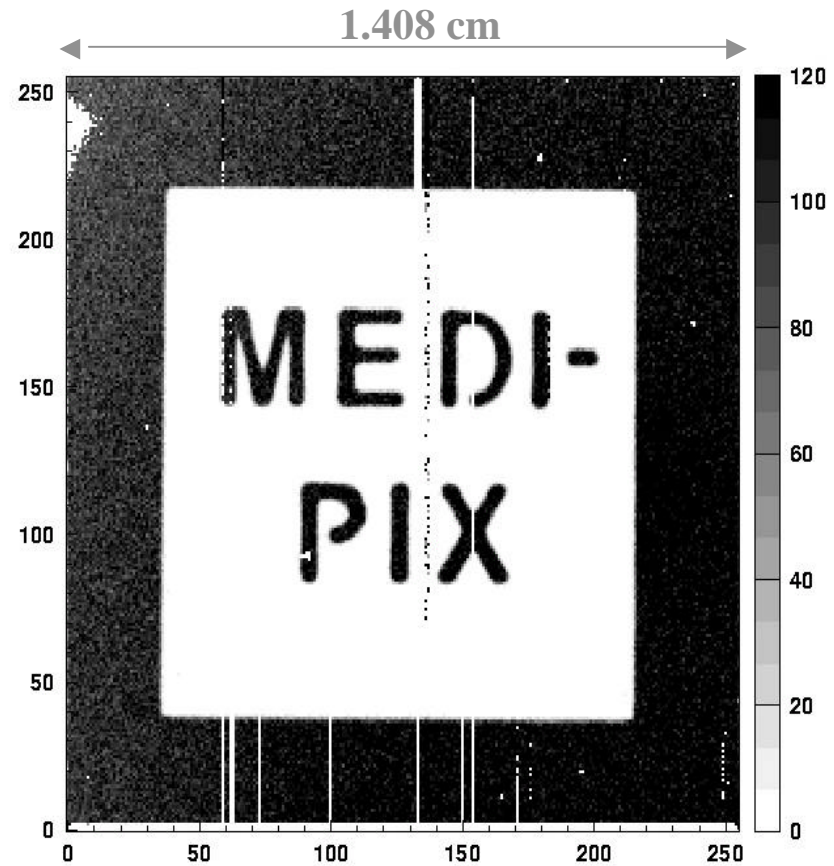
^{109}Cd Source comparison

Medipix1



1 hour acquisition
Threshold set to ~11KeV

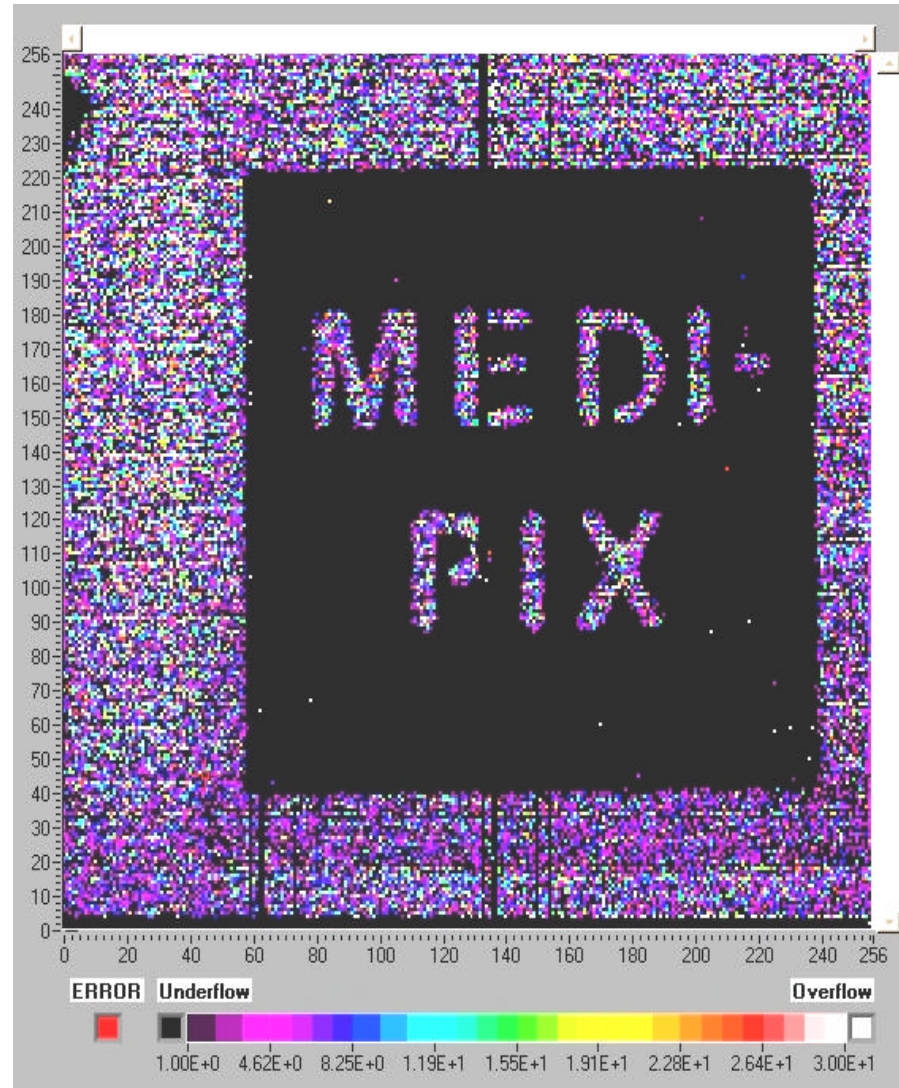
Medipix2





^{55}Fe Acquisition

10min acquisition
Threshold set to ~4 KeV



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Future Challenges

- ✍ **Spectroscopic pixels**
 - ✍ **Implies local charge summing**
- ✍ **Very fast counting (1MHz randomly arriving)**
- ✍ **millisec frame readout**
- ✍ **Dead time free readout**
- ✍ **Large area tiling**
- ✍ **Uniform high-Z materials**



“Idephix” IP proposal for FP6



CERN, ESRF, PSI